TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MH540FK,TC7MH541FK

Octal Bus Buffer

TC7MH540FK Inverted, 3-State Outputs TC7MH541FK Non-Inverted, 3-State Outputs

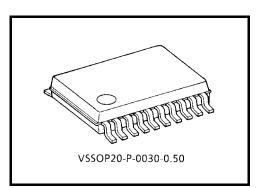
The TC7MH540FK and TC7MH541FK are advanced high speed CMOS octal bus buffers fabricated with silicon gate $\rm C^2MOS$ technology.

They achieve the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

The TC7MH540FK is an inverting type, and the TC7MH541FK is a non-inverting type.

When either $\overline{G}1$ or $\overline{G}2$ are high, the terminal outputs are in the high-impedance state.

An input protection circuit ensures that 0 to $5.5 \, \text{V}$ can be applied to the input pins without regard to the supply voltage. This device can be used to interface $5 \, \text{V}$ to $3 \, \text{V}$ systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

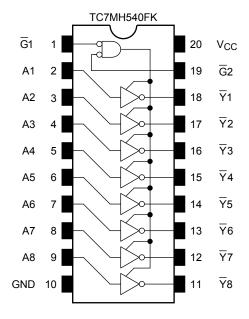


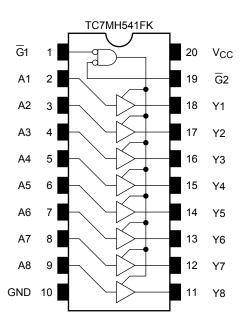
Weight: 0.03 g (typ.)

Features

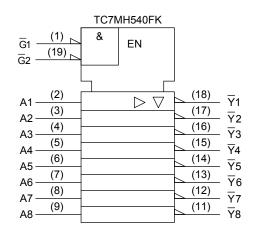
- High speed: $t_{pd} = 3.7 \text{ ns (typ.)} (V_{CC} = 5 \text{ V})$
- Low power dissipation: $I_{CC} = 4 \mu A \text{ (max) (Ta} = 25^{\circ}\text{C)}$
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: $V_{CC \text{ (opr)}} = 2 \sim 5.5 \text{ V}$
- Low noise: $V_{OLP} = 1.0 \text{ V (max)}$
- Pin and function compatible with 74ALS540/541

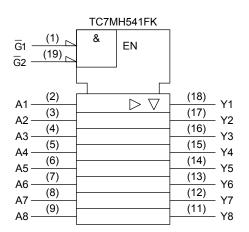
Pin Assignment (top view)





IEC Logic Symbol





Truth Table

	Inputs	Outputs				
G1	G2	An	Y _n (541)	Ÿ _n (540)		
Н	Х	Х	Z	Z		
Х	Н	Х	Z	Z		
L	L	Н	Н	L		
L	L	L	L	Н		

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X: Don't care

Z: High impedance

Yn: TC7MH541

Y_n: TC7MH540



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5~7.0	V
DC input voltage	V _{IN}	-0.5~7.0	V
DC output voltage	V _{OUT}	-0.5~V _{CC} + 0.5	V
Input diode current	l _{IK}	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0~5.5	V	
Input voltage	V _{IN}	0~5.5	V	
Output voltage	V _{OUT}	0~V _{CC}	V	
Operating temperature	T _{opr}	-40~85	°C	
Input rise and fall time	dt/dv	$0\sim100~(V_{CC}=3.3\pm0.3~V)$	ns/V	
input rise and rail time	avav	0~20 (V _{CC} = 5 \pm 0.5 V)	113/ V	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

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Electrical Characteristics

DC Characteristics

Characteristics Symb		Symbol Test Condition			Ta = 25°C		Ta = -40~85°C		Unit		
		Symbol	rest Condition		V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic
						1.50	_	_	1.50	_	
High level Input voltage		V _{IH}	_		3.0~5.5	V _{CC} × 0.7	_	_	V _{CC} × 0.7	_	V
input voitage					2.0		_	0.50	_	0.50	V
	Low level V _{IL} –		_	3.0~5.5	١	_	V _{CC} × 0.3	_	V _{CC} × 0.3		
					2.0	1.9	2.0	_	1.9	_	
		Vон	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -50 \mu A$	3.0	2.9	3.0	_	2.9	_	V
Output voltage	High level				4.5	4.4	4.5	_	4.4	_	
				$I_{OH} = -4 \text{ mA}$	3.0	2.58		_	2.48	_	
				$I_{OH} = -8 \text{ mA}$	4.5	3.94		_	3.80	_	
		V _{OL}	V _{IN} = V _{IH} or V _{IL}	Ι _{ΟL} = 50 μΑ	2.0	_	0	0.1	_	0.1	
	Low level				3.0	_	0	0.1	_	0.1	
					4.5	_	0	0.1		0.1	
				$I_{OL} = 4 \text{ mA}$	3.0	_	_	0.36	_	0.44	
			$I_{OL} = 8 \text{ mA}$	4.5	_	_	0.36	_	0.44		
3-state output off-state current I_{OZ} $V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND		5.5	_		±0.25	_	±2.50	μΑ			
Input leakage cu	rrent	I _{IN}	V _{IN} = 5.5 V or GND		0~5.5		_	±0.1	_	±1.0	μΑ
Quiescent supply	y current	Icc	V _{IN} = V _{CC} or GND		5.5	_	_	4.0	_	40.0	μΑ



AC Characteristics (Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40~85°C		Unit
Characteristics	Symbol	rest Condition	V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	Offic
		_	3.3 ± 0.3	15	_	4.8	7.0	1.0	8.5	ns
Propagation delay time	t _{pLH}			50	_	7.3	10.5	1.0	12.0	
(TC7MH540FK)	tpHL		50.05	15	_	3.7	5.0	1.0	6.0	115
			5.0 ± 0.5	50	_	5.2	7.0	1.0	8.0	
			3.3 ± 0.3	15		5.0	7.0	1.0	8.5	
Propagation delay time	t _{pLH}		3.3 ± 0.3	50		7.5	10.5	1.0	12.0	ne
(TC7MH541FK)	tpHL	_	50+05	15		3.5	5.0	1.0	6.0	ns
			5.0 ± 0.5	50		5.0	7.0	1.0	8.0	
3-state output enable time	t _{pZL} t _{pZH}	$R_L = 1 \text{ k}\Omega$	3.3 ± 0.3	15		6.8	10.5	1.0	12.5	ns
				50		9.3	14.0	1.0	16.0	
3-state output eriable time			5.0 ± 0.5	15		4.7	7.2	1.0	8.5	
				50		6.2	9.2	1.0	10.5	
3-state output disable time	t _{pLZ}	$R_L = 1 k\Omega$	3.3 ± 0.3	50		11.2	15.4	1.0	17.5	ns
5-state output disable time	t _{pHZ}	NL = 1 K22	5.0 ± 0.5	50		6.0	8.8	1.0	10.0	115
Output to output skew	t _{osLH}	(Note 1)	3.3 ± 0.3	50		_	1.5	_	1.5	ns
Output to output skew	t _{osHL}	(Note 1)	5.0 ± 0.5	50		_	1.0	_	1.0	115
Input capacitance	C _{IN}	_		_	4	10	_	10	pF	
Output capacitance	C _{OUT}	_			6				pF	
Power dissipation		TC7MH540FK		_	17	_	_	_	- pF	
capacitance (Note 2)	C _{PD}	TC7MH541FK			18	_	_	_		

Note 1: Parameter guaranteed by design.

 $t_{OSLH} = |t_{DLHm} - t_{DLHn}|, t_{OSHL} = |t_{DHLm} - t_{DHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$

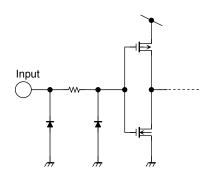


Noise Characteristics (Input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		- Unit
Citalacteristics	Symbol	rest condition	V _{CC} (V)	Тур.	Limit	Oill
Quiet output maximum dynamic V _{OL}	V _{OLP}	C _L = 50 pF	5.0	0.7	1.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	C _L = 50 pF	5.0	-0.7	-1.0	V
Minimum high level dynamic input voltage V_{IH}	V _{IHD}	C _L = 50 pF	5.0	_	1.5	V
Maximum low level dynamic input voltage V_{IL}	V _{ILD}	C _L = 50 pF	5.0	_	3.5	V

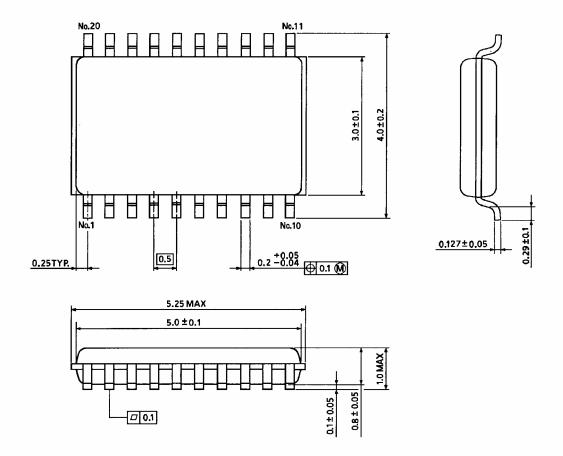
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Input Equivalent Circuit





Package Dimensions



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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